

Search Notes

Application/Control No.

10/609,452

Examiner

Paul D. Kim

Applicant(s)/Patent under
Reexamination

HE ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	592.1 605 830-832 846 854	10/20/2005	PK
174	52.1 255		
	260 261		
607	1-3 46-52		
	59-61		
600	302 554 377		
127	877	✓	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search EAST/NPL (IEEE)	10/26/2005	PK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner